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查询STE15N100供应商

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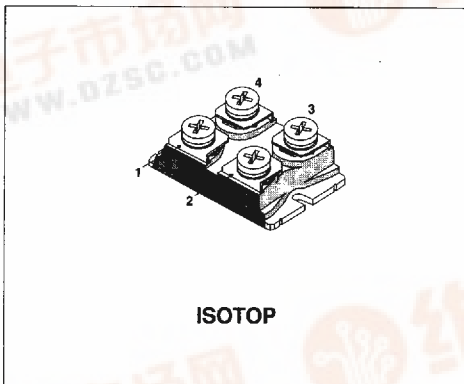
**SGS-THOMSON**  
MICROELECTRONICS

**STE15N100**

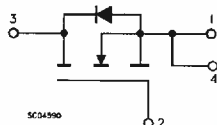
## N - CHANNEL ENHANCEMENT MODE POWER MOS TRANSISTOR IN ISOTOP PACKAGE

| TYPE      | V <sub>DS</sub> | R <sub>DS(on)</sub> | I <sub>D</sub> |
|-----------|-----------------|---------------------|----------------|
| STE15N100 | 1000 V          | < 0.77 Ω            | 15 A           |

- HIGH CURRENT POWER MODULE
- AVALANCHE RUGGED TECHNOLOGY (SEE STH6N100 FOR RATING)
- VERY LARGE SOA - LARGE PEAK POWER CAPABILITY
- EASY TO MOUNT
- SAME CURRENT CAPABILITY FOR THE TWO SOURCE TERMINALS
- EXTREMELY LOW R<sub>th</sub> JUNCTION TO CASE
- VERY LOW DRAIN TO CASE CAPACITANCE
- VERY LOW INTERNAL PARASITIC INDUCTANCE (TYPICALLY < 5 nH)
- ISOLATED PACKAGE UL RECOGNIZED (FILE No E81743)



### INTERNAL SCHEMATIC DIAGRAM



### INDUSTRIAL APPLICATIONS:

- SMPS & UPS
- MOTOR CONTROL
- WELDING EQUIPMENT
- OUTPUT STAGE FOR PWM, ULTRASONIC CIRCUITS

### ABSOLUTE MAXIMUM RATINGS

| Symbol              | Parameter   | Value      | Unit |
|---------------------|---|------------|------|
| V <sub>DS</sub>     | Drain-Source Voltage (V <sub>GS</sub> = 0)            | 1000       | V    |
| V <sub>DGR</sub>    | Drain-Gate Voltage (R <sub>GS</sub> = 20 kΩ)          | 1000       | V    |
| V <sub>GS</sub>     | Gate-Source Voltage                                   | ± 20       | V    |
| I <sub>D</sub>      | Drain Current (continuous) at T <sub>c</sub> = 25 °C  | 15         | A    |
| I <sub>D</sub>      | Drain Current (continuous) at T <sub>c</sub> = 100 °C | 9.5        | A    |
| I <sub>DM</sub> (*) | Drain Current (pulsed)                                | 60         | A    |
| P <sub>tot</sub>    | Total Dissipation at T <sub>c</sub> = 25 °C           | 400        | W    |
|                     | Derating Factor                                       | 3.2        | W/°C |
| T <sub>stg</sub>    | Storage Temperature                                   | -55 to 150 | °C   |
| T <sub>j</sub>      | Max. Operating Junction Temperature                   | 150        | °C   |
| V <sub>iso</sub>    | Insulation Withstand Voltage (AC-RMS)                 | 2500       | V    |

(\*) Pulse width limited by safe operating area

## THERMAL DATA

|                  |  |     |      |                             |
|------------------|--|-----|------|-----------------------------|
| $R_{th(j-case)}$ | Thermal Resistance Junction-case                                 | Max | 0.31 | $^{\circ}\text{C}/\text{W}$ |
| $R_{th(c-h)}$    | Thermal Resistance Case- heatsink With Conductive Grease Applied | Max | 0.05 | $^{\circ}\text{C}/\text{W}$ |

ELECTRICAL CHARACTERISTICS ( $T_{case} = 25^{\circ}\text{C}$  unless otherwise specified)

## OFF

| Symbol         | Parameter  | Test Conditions   | Min. | Typ. | Max.       | Unit                |
|----------------|--|---|------|------|------------|---------------------|
| $V_{(BR),DSS}$ | Drain-source Breakdown Voltage                   | $I_D = 1\text{ mA}$ $V_{GS} = 0\text{ V}$   | 1000 |      |            | V                   |
| $I_{DSS}$      | Zero Gate Voltage Drain Current ( $V_{GS} = 0$ ) | $V_{DS} = \text{Max Rating}$<br>$V_{DS} = \text{Max Rating} \times 0.8$ $T_c = 125^{\circ}\text{C}$ |      |      | 500<br>1.5 | $\mu\text{A}$<br>mA |
| $I_{GSS}$      | Gate-body Leakage Current ( $V_{DS} = 0$ )       | $V_{GS} = \pm 20\text{ V}$  |      |      | $\pm 300$  | nA                  |

## ON (\*)

| Symbol       | Parameter                         | Test Conditions                           | Min. | Typ. | Max. | Unit     |
|--------------|-----------------------------------|---|------|------|------|----------|
| $V_{GS(th)}$ | Gate Threshold Voltage            | $V_{DS} = V_{GS}$ $I_D = 1\text{ mA}$     | 2    |      | 4    | V        |
| $R_{DS(on)}$ | Static Drain-source On Resistance | $V_{GS} = 10\text{ V}$ $I_D = 9\text{ A}$ |      |      | 0.77 | $\Omega$ |

## DYNAMIC

| Symbol       | Parameter                    | Test Conditions   | Min. | Typ. | Max. | Unit |
|--------------|------------------------------|---|------|------|------|------|
| $g_{fs} (*)$ | Forward Transconductance     | $V_{DS} = 15\text{ V}$ $I_D = 9\text{ A}$                       | 8    |      |      | S    |
| $C_{iss}$    | Input Capacitance            | $V_{DS} = 25\text{ V}$ $f = 1\text{ MHz}$ $V_{GS} = 0\text{ V}$ |      |      | 7    | nF   |
| $C_{oss}$    | Output Capacitance           |   |      |      | 850  | pF   |
| $C_{rss}$    | Reverse Transfer Capacitance |   |      |      | 250  | pF   |

## SWITCHING ON

| Symbol         | Parameter             | Test Conditions   | Min. | Typ. | Max. | Unit             |
|----------------|-----------------------|---|------|------|------|------------------|
| $t_{d(on)}$    | Turn-on Time          | $V_{DD} = 500\text{ V}$ $I_D = 9\text{ A}$<br>$R_G = 4.7\ \Omega$ $V_{GS} = 10\text{ V}$<br>(see test circuit, figure 1)  |      | 65   |      | ns               |
| $t_r$          | Rise Time             |   |      | 78   |      | ns               |
| $(di/dt)_{on}$ | Turn-on Current Slope | $V_{DD} = 800\text{ V}$ $I_D = 15\text{ A}$<br>$R_G = 4.7\ \Omega$ $V_{GS} = 10\text{ V}$<br>(see test circuit, figure 3) |      | 570  |      | A/ $\mu\text{s}$ |
| $Q_g$          | Total Gate Charge     | $V_{DD} = 800\text{ V}$ $I_D = 15\text{ A}$<br>$V_{GS} = 10\text{ V}$   |      | 375  |      | nC               |

**ELECTRICAL CHARACTERISTICS** (continued)

**SWITCHING OFF**

| Symbol        | Parameter             | Test Conditions                             | Min. | Typ. | Max. | Unit |
|---------------|-----------------------|---|------|------|------|------|
| $t_{r(voff)}$ | Off-voltage Rise Time | $V_{DD} = 800\text{ V}$ $I_D = 15\text{ A}$ |      | 75   | 95   | ns   |
| $t_f$         | Fall Time             | $R_G = 4.7\ \Omega$ $V_{GS} = 10\text{ V}$  |      | 18   | 25   | ns   |
| $t_c$         | Cross-over Time       | (see test circuit, figure 3)                |      | 105  | 136  | ns   |

**SOURCE DRAIN DIODE**

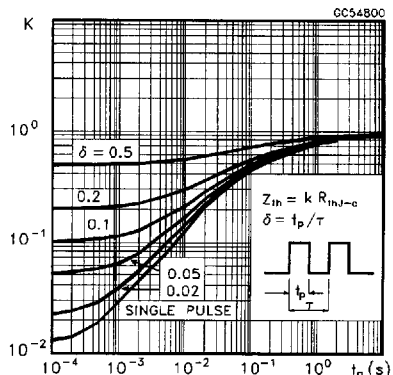
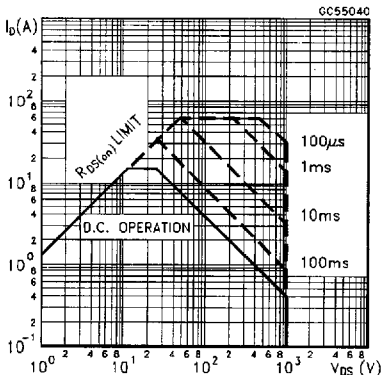
| Symbol             | Parameter                     | Test Conditions  | Min. | Typ. | Max. | Unit          |
|--------------------|-------------------------------|--|------|------|------|---------------|
| $I_{SD}$           | Source-drain Current          |  |      |      | 15   | A             |
| $I_{SDM}(\bullet)$ | Source-drain Current (pulsed) |  |      |      | 60   | A             |
| $V_{SD}(\ast)$     | Forward On Voltage            | $I_{SD} = 15\text{ A}$ $V_{GS} = 0$  |      |      | 2.5  | V             |
| $t_{rr}$           | Reverse Recovery Time         | $I_{SD} = 15\text{ A}$ $di/dt = 100\text{ A}/\mu\text{s}$<br>$V_{DD} = 100\text{ V}$ $T_J = 150\text{ }^\circ\text{C}$<br>(see test circuit, figure 3) |      | 1150 |      | ns            |
| $Q_{rr}$           | Reverse Recovery Charge       |  |      | 30   |      | $\mu\text{C}$ |
| $I_{RRM}$          | Reverse Recovery Current      |  |      | 52   |      | A             |

(\*) Pulsed: Pulse duration = 300  $\mu\text{s}$ , duty cycle 1.5%

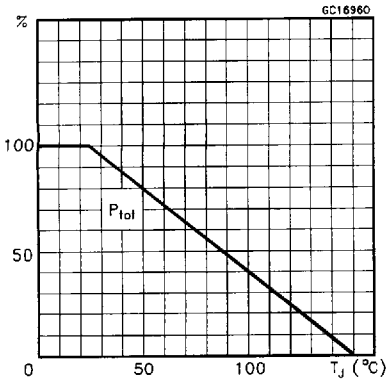
(•) Pulse width limited by safe operating area

**Safe Operating Area**

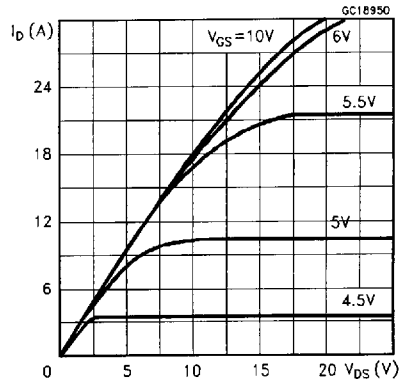
**Thermal Impedance**



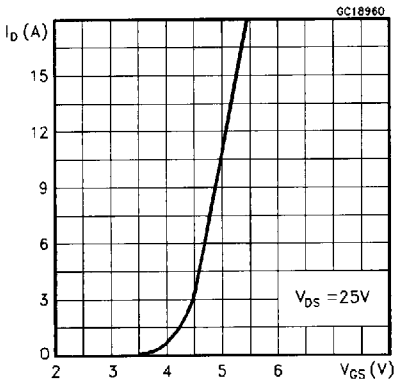
Derating Curve



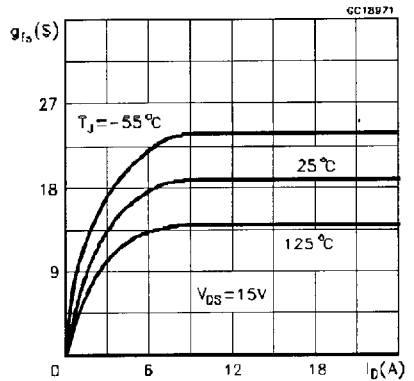
Output Characteristics



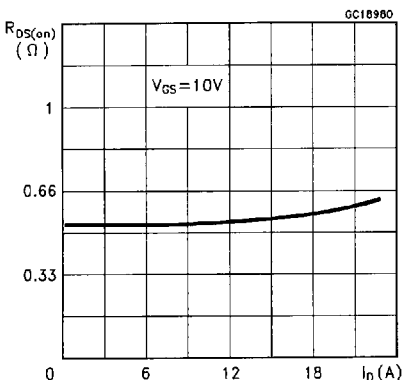
Transfer Characteristics



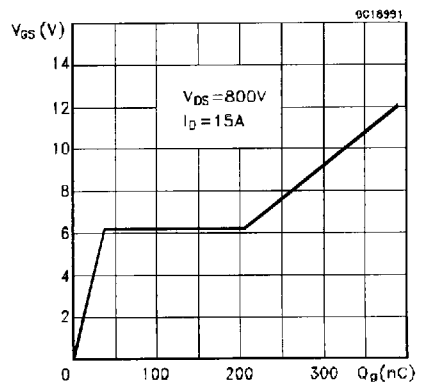
Transconductance



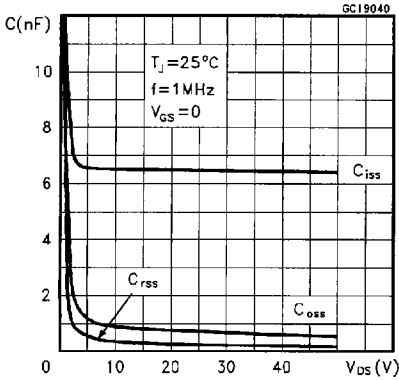
Static Drain-source On Resistance



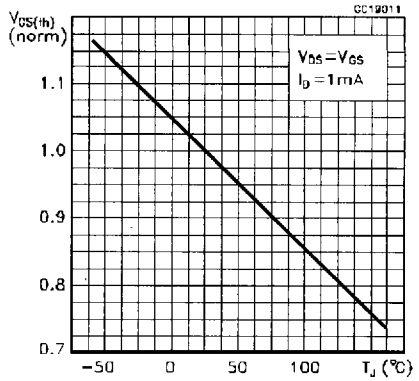
Gate Charge vs Gate-source Voltage



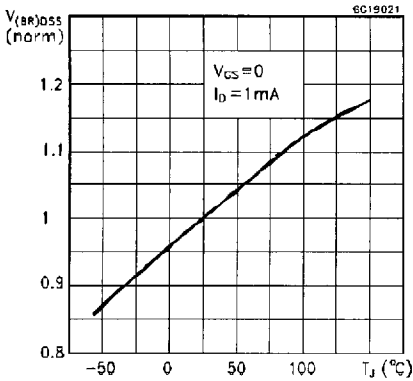
Capacitance Variations



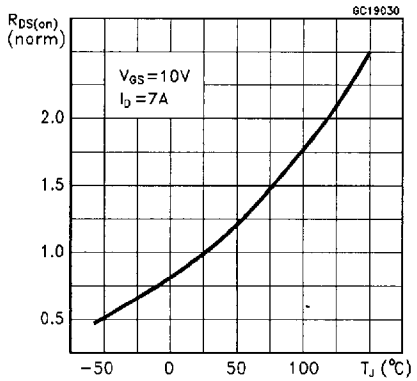
Normalized Gate Threshold Voltage vs Temperature



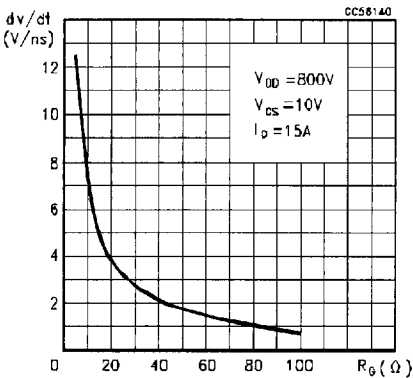
Normalized Breakdown Voltage vs Temperature



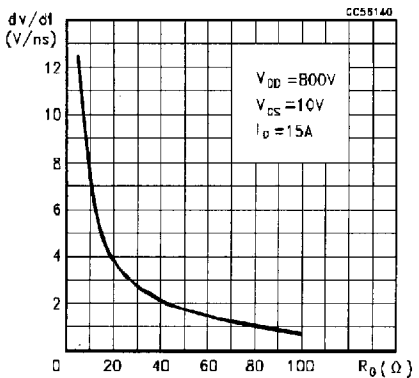
Normalized On Resistance vs Temperature



Turn-on Current Slope



Turn-off Drain-source Voltage Slope



Cross-over Time

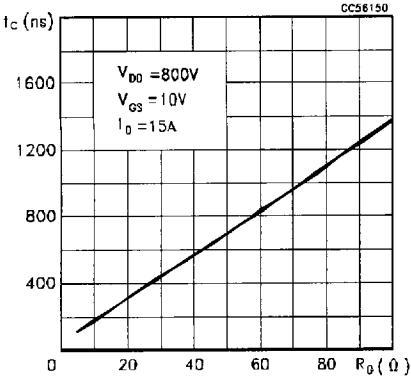
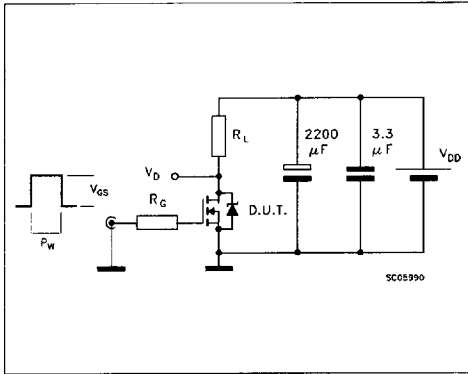


Fig. 1: Switching Times Test Circuits For Resistive Load



Source-drain Diode Forward Characteristics

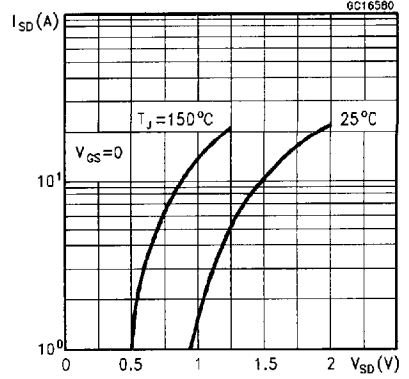


Fig. 2: Gate Charge Test Circuit

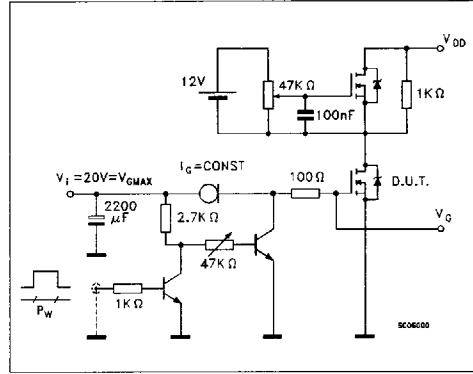


Fig. 3: Test Circuit For Inductive Load Switching And Diode Recovery Times

